



Imago invites you to attend

A Users Group Meeting on FIB Specimen Preparation for the Atom Probe Microscope:

*Presentations, Panel Discussion, Chili Pepper Tasting, and Cocktails
Held in Conjunction with Microscopy and Microanalysis 2008 - Invitation Only*

Tuesday, August 5th

6:30 PM – 9 PM

Albuquerque, New Mexico

Please RSVP for an invitation and room location

The instrumentation and techniques for Dual Beam Focused Ion Beam (FIB) based Atom Probe specimen preparation are evolving rapidly in sophistication and capability. Prior to the availability of highly capable commercial Atom Probe Microscopes having a successful research program required considerable instrumentation expertise. With the introduction of Imago's LEAP, the instrumentation ease of use has evolved to the point where FIB specimen preparation has is now a required core competence for utilizing the power of Atom Probe Microscopy instrumentation for scientific discovery.

This meeting is targeted at: (1) users and developers of FIB based Atom Probe specimen preparation instrumentation and techniques including Atom Probe owners, prospective owners, and collaborators; (2) select vendors of both Dual Beam and Atom Probe equipment. The agenda is designed to facilitate the exchange of information and identification of important areas for future development in a relaxed, southwestern atmosphere.

Agenda:

- 1. Specimen Preparation Techniques and Results**
- 2. Advances in Specimen Preparation Instrumentation**
- 3. KEY NOTE: Chili Pepper Production and Classification**
- 4. Panel Discussion (questions submitted in advance)**

Please RSVP Through The Imago Web Site

